Sear	rch No	otes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/735,769	KAWAMURA ET AL.	
Examiner	Art Unit	
Dahorah Chacko-Davis	1795	

SEARCHED			
Class	Subclass	Date	Examiner
			,
			-

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
interference search-see updated search history print out		11/2/2007	DCD

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
updated text search only-see updated search history print out	11/5/2007	DCD
EAST (US-PGPUB, USPAT, FPRS, EPO, JPO, DERWENT, IBM-TDB) See updated search history print out	11/5/2007	DCD
Updated eDAN inventor search	11/2/2007	DCD
Updated search history print out	11/6/2007	DCD
•		